Automated Defect Detection System for Surgical Instruments

Technology ID
2026-ZHU-71303

Unsupervised AI automates consistent and objective defect detection for surgical instruments in sterile processing and quality assurance, minimizing human error and inspection fatigue.

Researchers at Purdue University developed a system that implements unsupervised defect detection for surgical instrument images. This technology facilitates clinical inspection and quality assurance by providing automated, objective, and interpretable identification and visualization of defects in surgical instruments. Compared to manual human inspection, which is a time-consuming and error-prone process that relies on human attention and expertise, this technology addresses the need for a more consistent objective and scalable solution by automating the detection of such defects using a trained neutral network. This automated system delivers repeatable and reliable results to minimize the risk of human errors, unlike human inspectors that are susceptible to fatigue, distraction, and variability in judgement. Additionally, this unsupervised approach does not rely on label-intensive annotation and is trained on defect-free images. This technology is practical and scalable in real-world clinical settings, improving inspection accuracy and supporting higher standards of quality control.

Technology Validation: The system has been trained and tested on clean surgical instrument images, demonstrating its ability to detect defects through reconstruction error. Visualization tools such as defect score maps and segmentation masks have been implemented to support intuitive interpretation.

Advantages:

-Eliminates need for labeled defect data

-Consistent and objective defect detection

-Scalable for real-world clinical use

-Reduces human error and inspection fatigue

Category

Artificial Intelligence & Machine Learning/Computer Vision & Image Recognition
Robotics & Automation/Perception & Sensing
Artificial Intelligence & Machine Learning/AI-Integrated Imaging Systems & Industrial Vision and Inspection
Medtech & Digital Health/Medical Image Processing

Authors

Fengqing Maggie Zhu
Yichi Zhang
Jingxi Yu
Amy Ruth Reibman
Qiang Qiu
Seunghyun Hwang
Joseph Jun-Sheng Huang
Edward John Delp III
Wei Chen
Edward Delp III
Joseph Huang
Amy Reibman
Fengqing Zhu

Further information

Aaron Taggart
adtaggart@prf.org

View online

-Enables intuitive visualization of anomalies

Applications:

-Sterile processing departments in hospitals

-Surgical instrument quality assurance

-Medical device manufacturing inspection

-Automated clinical workflow integration

-AI-powered hospital safety systems

Related Publications: https://arxiv.org/abs/2509.21561

TRL: 3

Intellectual Property:

Provisional-Patent, 2025-09-08, United States

Keywords: Unsupervised defect detection,Surgical instrument QA,AI quality control,Medical device inspection,Sterile processing,Anomaly detection,Automated inspection,Deep learning inspection,Defect score map,Clinical instrument safety, anomaly detection, bioburden, Biomedical Engineering, clinical quality assurance, Computer Technology, convolutional autoencoder, defect detection, Electrical Engineering, hospital workflow automation, Medical Imaging, sterile processing, surgical instrument inspection, unsupervised learning